

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

# PRODUCT SPECIFICATION 規格書

**CUSTOMER:** DATE:

(客戶): (日期):2017-11-16

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : GT 16V8200μF(φ18X35)

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPI	LIER
PREPARED (拟定)	CHECKED (审核)
李婷	刘渭清

CUST	TOMER
APPROVAL (批准)	SIGNATURE (签名)

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		SPECIFICAT			ALTERNA	ATION HIS ECORDS	TORY
		GT SERIE	ES				
Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver

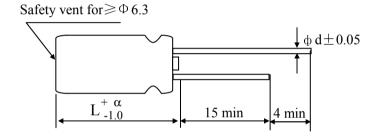
Version 01 Page 1
-------------------

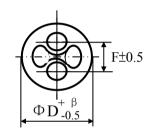
## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

### Table 1 Product Dimensions and Characteristics

Unit: mm





α	L<20 : α=1.5; L≥20 : α=2.0
β	$\Phi D < 20 : \beta = 0.5; \Phi D \ge 20 : \beta = 1.0$

\* If it is flat rubber, there is no bulge from the flat rubber surface.

N	SAMXON	WV	Cap.	Cap. tolerance	Temp.	tanδ (120Hz,	Leakage	Max Ripple Current at 105℃	Impedance at 20°C	Load lifetime	Dim	nensior (mm)	1	Sleev
0.	Part No.	(Vdc)	)	Cap. tolerance	range(°C)	20°C)	Current (μ <b>A</b> ,2min)	100KHz (mA rms)	100kHz (Ωmax)	(Hrs)	$D \times L$	F	фd	e
1	EGT828M1CL35RR**P	16	8200	-20%~+20%	-40~105	0.16	1312	3638	0.019	10000	18X35	7.5	0.8	PET

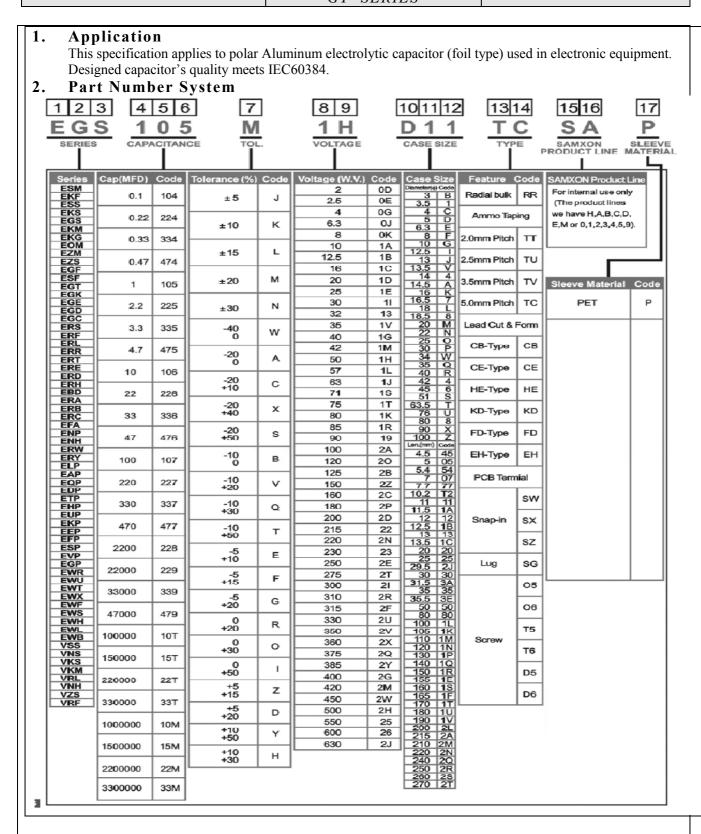
Version	01	Page	2

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

#### CONTENTS **Sheet** Application 4 1. 2. Part Number System 4 3. Construction 5 4. Characteristics 5~10 4.1 Rated voltage & Surge voltage 4.2 Capacitance (Tolerance) 4.3 Leakage current 4.4 $tan \delta$ 4.5 Terminal strength 4.6 Temperature characteristic 4.7 Load life test 4.8 Shelf life test 4.9 Surge test 4.10 Vibration 4.11 Solderability test 4.12 Resistance to solder heat 4.13 Change of temperature 4.14 Damp heat test 4.15 Vent test 4.16 Maximum permissible (ripple current) 5. Packing Information 11 6. List of "Environment-related Substances to be Controlled ('Controlled 12 Substances')" Attachment: Application Guidelines 13~16

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

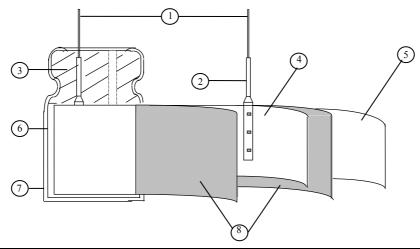


## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

#### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

#### 4. Characteristics

#### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C Relative humidity : 45% to 85% Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature  $: 20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

#### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

Version	01		Page	5
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

	ITEM				PERFO	RMANC	CE			
	Rated voltage (WV)									
4.1		WV (V.DC)	6.3	10	16	25	35	50	63	100
	Surge voltage (SV)	SV (V.DC)	8	13	20	32	44	63	79	125
4.2	Nominal capacitance (Tolerance)	<b>Condition&gt;</b> Measuring F Measuring V Measuring T <b>Criteria&gt;</b> Shall be with	oltage emperat	: N ure : 20	.0Hz±12 ot more t 0±2°C	han 0.5V				
4.3	Leakage current	Condition> Connecting t minutes, and  Criteria> Refer to Table	then, me		•		istor (1	k Ω ± 10	DΩ) in s	eries for
4.4	tan δ	<condition> See 4.2, Norn <criteria> Refer to Table</criteria></condition>	-	itance, fo	or measur	ing frequ	iency, vo	ltage and	d tempera	ature.
4.5	Terminal strength	0.5r Over 0.	ength of apacitor ength of apacitor, 2~3 seconder of lead num and 15 mm to	f Termina applied f applied f ands, and d wire	Tens	ent the tent it for 9  ile force (kgf)  5 (0.51)  0 (1.0)	erminal (10° to its	Bending (kg 2.5 (0	from the position of force N gf) 0.25) .51)	rubber) for within 2~

Version	01		Page	6
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		<condition></condition>								
		STEP	Testir	ng Tempe	rature(°C)			Time		
		1		$20 \pm 2$	2	Time	to reach	thermal e	equilibriu	ım
		2		-40(-25)	±3	Time	to reach	thermal e	equilibriu	ım
		3		$20\pm 2$	2	Time	to reach	thermal e	equilibriu	ım
		4		105±	2	Time	to reach	thermal e	equilibrii	ım
		5		$20\pm 2$		_	to reach			
		<criteria></criteria>							1	··
		a. tan δ shall be	e withi	in the lim	it of Item	4.4The le	eakage cu	ırrent me	easured s	hall not
		more than 8 time					C			
	Temperature	b. In step 5, tan	ı δ sha	ıll be with	nin the lin	it of Iter	n 4.4The	leakage	current	shall not
4.6	characteristi	more than the sp								
4.0	cs	c. At-40°C (-25°	°C), ir	npedance	(z) ratio s	hall not	exceed th	e value o	of the fol	lowing
		table.	-		T T			1	ı	ı
		Working Voltage	` ′	6.3	10	16	25	35	50	63
		Z-25°C/Z+20°C		4	3	2	2	2	2	2
		Z-40°C/Z+20°C	С	8	6	4	3	3	3	3
		Working Voltage	(V)	100						
		Z-25°C/Z+20°C		2						
		Z-40°C/Z+20°C		3						
		For capacitance v			 	nor one	thar 1000	) u E for	7 25/74	20℃
		roi capacitance v	varue -	- 1000 μ	r, Auu u	per ano	uici iooc	) M I 101	L-23/L	20 C,
					Δdd 1 (	ner anot	her 1000	u F for	<b>7-</b> 40°C/7	7+20°C
		Capacitance, tan 8	$\delta$ , and	l impedan		•	ther 1000 ed at 120		Z-40°C/Z	Z+20°C.
		Capacitance, tan 8	δ, and	l impedan		•			Z-40°C/Z	Z+20°C.
					ice shall b	e measur	ed at 120	Hz.		
		Condition> According to IEC 105°C ±2 with I	C6038 DC bia	4-4No.4.	13 method	s, The ca	pacitor is	oHz. s stored a t for Tab	at a tempe ole 1. (Ti	erature o
		Condition> According to IEC 105°C ±2 with I DC and ripple p	C6038 DC bia	4-4No.4. as voltage	13 methode plus the reall not ex	s, The carated ripp	pacitor is le current rated w	S stored at for Tab	at a tempe ble 1. (The voltage)	erature o he sum o Then the
		Condition> According to IEC 105°C ±2 with I DC and ripple p product should be	C6038 DC bia beak v	4-4No.4. as voltage voltage sh	13 methode plus the reall not explusive process.	s, The carated ripp	pacitor is le current rated w	S stored at for Tab	at a tempe ble 1. (The voltage)	erature o he sum o Then the
	Load	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee	C6038 DC bia beak v	4-4No.4. as voltage voltage sh	13 methode plus the reall not explusive process.	s, The carated ripp	pacitor is le current rated w	S stored at for Tab	at a tempe ble 1. (The voltage)	erature o he sum o Then the
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee	C6038 DC bia beak ve teste et the	4-4No.4. as voltage soltage shed after 16 following	13 method e plus the rall not ex 6 hours rec g table:	s, The ca ated ripp acceed the	pacitor is le current e rated with the rated with the rated with the rated with the rate at at	S stored at for Tab	at a tempe ble 1. (The voltage)	erature o he sum o Then the
4.7		Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi</criteria>	C6038 DC bia beak ve teste et the	4-4No.4. as voltage shed after 16 following	13 methode plus the real not expluse the real not expluse the real to the real	s, The ca ated ripp acced the covering	pacitor is le current rated writing at at ments.	s stored a t for Tab orking v mospher	at a tempe ble 1. (The voltage)	erature o he sum o Then the
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi Leakage c	C6038 DC bia beak ve teste et the ic shale	4-4No.4. as voltage voltage shed after 16 following	13 method e plus the real not ex 6 hours red g table: e followin	s, The carated ripp acceed the covering g require 4.3 shall	pacitor is le curren e rated whime at at ments.	s stored a t for Tab vorking v mospher	at a tempe ble 1. (The voltage)	erature o he sum o Then the
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi Leakage c Capacitane</criteria>	C6038 DC bia beak ve teste et the ic shale	4-4No.4. as voltage voltage shed after 16 following	13 methode plus the reall not expluse the reall not expluse the real to hours reall table:  e following Value in Within ±	s, The ca ated ripp acced the covering g require 4.3 shall 25% of	pacitor is le current e rated white at at ments.	s stored a t for Tab yorking v mospher ied	at a tempole 1. (Ti voltage) ic condit	erature o he sum o Then the
4.7	life	<condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi Leakage c Capacitane tan δ</criteria></condition>	C6038 DC bia beak ve teste et the ic shale current ace Ch	4-4No.4. as voltage voltage shed after 16 following	13 methode plus the reall not explusive following table:  e following Value in Within ± Not more	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200	pacitor is le currente rated we time at at ments.  be satisfication with the part of the p	s stored a t for Tab yorking v mospher ied alue.	at a tempo ble 1. (The voltage) ic condit	erature o he sum o Then the
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi Leakage c Capacitane</criteria>	C6038 DC bia beak ve teste et the ic shale current ace Ch	4-4No.4. as voltage voltage shed after 16 following	13 methode plus the reall not expluse the reall not expluse the real to hours reall table:  e following Value in Within ±	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200	pacitor is le currente rated we time at at ments.  be satisfication with the part of the p	s stored a t for Tab yorking v mospher ied alue.	at a tempo ble 1. (The voltage) ic condit	erature o he sum o Then the
4.7	life	<condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi Leakage c Capacitane tan δ Appearane</criteria></condition>	C6038 DC bia beak ve teste et the ic shale current ace Ch	4-4No.4. as voltage voltage shed after 16 following	13 methode plus the reall not explusive following table:  e following Value in Within ± Not more	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200	pacitor is le currente rated we time at at ments.  be satisfication with the part of the p	s stored at for Tabyorking working wor	at a tempo ble 1. (The voltage) ic condit	erature o he sum o Then the
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi Leakage c Capacitane tan δ Appearance Condition>	C6038 DC bia beak ve teste et the ic shale current ice Ch	4-4No.4. as voltage shod after 16 following the that the that ange	13 methode plus the real not explain the real not explain the real table:  e followin Value in Within ± Not more There shall	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial value of the leakage of	s stored a t for Tab vorking v mospher ied alue.	at a tempole 1. (The voltage) ic condited value.	erature o he sum o Then the ions. The
4.7	life	<condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee <criteria> The characteristi Leakage c Capacitane tan δ Appearane</criteria></condition>	C6038 DC bia beak ve teste et the ic shale current ice Ch	4-4No.4. as voltage shed after 16 following ll meet the t ange	13 methode plus the real not explusive following table:  e following Within ±  Not more there should be sh	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le currente rated writine at at ments. be satisficial value of the leakage of the lea	s stored a t for Tab yorking v mospher ied alue. e specifie of electro	at a tempo ble 1. (The voltage) ic conditued value.	erature of the sum of the thousand the thous
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi	C6038 DC bia beak vertexteet the ic shall current ice Ch ce e then s. Follo	4-4No.4. as voltage voltage shed after 16 following all meet the tange asstored wire owing this	13 method plus the pl	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated whime at at ments.  be satisficinitial various of the leakage of t	s stored at for Tabyorking was mospher died alue.	ed value.	erature o he sum o Then the ions. The
4.7	life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi  Leakage c Capacitant tan δ Appearance Condition> The capacitors are 1000+48/0 hours chamber and be shall be connected	C6038 DC bia beak ve teste et the ic shale current ice Ch ce et then s. Folloallow ed to	4-4No.4. as voltage shod after 16 following ll meet the tange stored with the stored with the tange stored with the tangent stored with the tangen	13 methode plus the real not explain the real not explain the real not explain the real not explain the real not make the real not explain the real not more than the real not explain the real not ex	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial va 20% of the leakage of the tors shall apperature to ± 100 Ω	s stored a t for Tab vorking with mospher metallue.  e specifie of electromagnetic for 4~8 ) with I	ed value.  The of 105 oved from hours. In O.C. rate	erature of the sum of the sum of the thousand the test they do voltage
4.7	life test	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi  Leakage c Capacitant tan δ Appearance  Condition> The capacitors are 1000+48/0 hours chamber and be shall be connected applied for 30min	C6038 DC bia beak ve teste et the ic shale current ice Ch ce et then s. Folloallow ed to	4-4No.4. as voltage shod after 16 following ll meet the tange stored with the stored with the tange stored with the tangent stored with the tangen	13 methode plus the real not explain the real not explain the real not explain the real not explain the real not make the real not explain the real not more than the real not explain the real not ex	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial va 20% of the leakage of the tors shall apperature to ± 100 Ω	s stored a t for Tab vorking with mospher metallue.  e specifie of electromagnetic for 4~8 ) with I	ed value.  The of 105 oved from hours. In O.C. rate	erature of the sum of
	life test  Shelf	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi  Leakage c Capacitant tan δ Appearance Condition> The capacitors are 1000+48/0 hours chamber and be shall be connected	C6038 DC bia beak ve teste et the ic shale current ice Ch ce et then s. Folloallow ed to	4-4No.4. as voltage shod after 16 following ll meet the tange stored with the stored with the tange stored with the tangent stored with the tangen	13 methode plus the real not explain the real not explain the real not explain the real not explain the real not make the real not explain the real not more than the real not explain the real not ex	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial va 20% of the leakage of the tors shall apperature to ± 100 Ω	s stored a t for Tab vorking with mospher metallue.  e specifie of electromagnetic for 4~8 ) with I	ed value.  The of 105 oved from hours. In O.C. rate	erature of the sum of
	life test  Shelf life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi  Leakage c Capacitant tan δ Appearance  Condition> The capacitors are 1000+48/0 hours chamber and be shall be connected applied for 30min	C6038 DC bia beak ve teste et the ic shale current ice Ch ce et then s. Folloallow ed to	4-4No.4. as voltage shod after 16 following ll meet the tange stored with the stored with the tange stored with the tangent stored with the tangen	13 methode plus the real not explain the real not explain the real not explain the real not explain the real not make the real not explain the real not more than the real not explain the real not ex	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial va 20% of the leakage of the tors shall apperature to ± 100 Ω	s stored a t for Tab vorking with mospher metallue.  e specifie of electromagnetic for 4~8 ) with I	ed value.  The of 105 oved from hours. In O.C. rate	erature of the sum of
	life test  Shelf life	Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should mee  Criteria> The characteristi  Leakage c Capacitant tan δ Appearance  Condition> The capacitors are 1000+48/0 hours chamber and be shall be connected applied for 30min	C6038 DC bia beak ve teste et the ic shale current ice Ch ce et then s. Folloallow ed to	4-4No.4. as voltage shod after 16 following ll meet the tange stored with the stored with the tange stored with the tangent stored with the tangen	13 methode plus the real not explain the real not explain the real not explain the real not explain the real not make the real not explain the real not more than the real not explain the real not ex	s, The ca ated ripp acced the covering g require 4.3 shall 25% of than 200 all be no	pacitor is le current e rated writine at at ments. be satisficinitial va 20% of the leakage of the tors shall apperature to ± 100 Ω	s stored a t for Tab vorking with mospher metallue.  e specifie of electromagnetic for 4~8 ) with I	ed value.  The of 105 oved from hours. In O.C. rate	erature of the sum of

Version 01 Page 7		l
-------------------	--	---

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		<a href="#">Criteria&gt;</a> The characteristic shall meet	the following requirements
		Leakage current	Value in 4.3 shall be satisfied
	Shelf	Capacitance Change	Within $\pm 25\%$ of initial value.
4.8	life	tan δ	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
		Remark: If the capacitors are increase. Please apply voltage	stored more than 1 year, the leakage current may e through about 1 k $\Omega$ resistor, if necessary.
4.9	Surge test	The capacitor shall be submirfollowed discharge of 5 min The test temperature shall b C <sub>R</sub> :Nominal Capacitance (   Criteria>  Leakage current  Capacitance Change  tan δ  Appearance  Attention:	Not more than the specified value.  Within ±15% of initial value.  Not more than the specified value.  There shall be no leakage of electrolyte.  ge at abnormal situation only. It is not applicable to such
4.10	Vibration test	perpendicular directions.  Vibration frequency ra Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter g in place with a bracket.  4mm or les <a href="#">Criteria&gt;</a> After the test, the following in Inner construction  Inner construction	: $1.5 \text{mm}$ : $10 \text{Hz} \sim 55 \text{Hz} \sim 10 \text{Hz}$ in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30° S  To be soldered

Version	01		Page	8
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

Condition> The capacitor shall be tested under the following conditions:   Solderability test   Dipping depth   : 2mm   Dipping speed   : 25±2.5mm/s   Dipping time   : 3±0.5s     Coating quality   A minimum of 95% of the surface being immersed								
Soldering temperature			<condition></condition>					
Solderability test   Dipping depth   1.2mm   Dipping speed   2.25±2.5mm/s   2.3±0.5s				_	conditions:			
Solderability test   Dipping speed   25±2.5mm/s   Dipping time   3±0.5s								
A minimum of 95% of the surface being immersed			11 0 1					
Coating quality   A minimum of 95% of the surface being immersed	4.11	-	11 0 1		n/s			
Coating quality		test		: 3±0.5s				
Condition			<criteria></criteria>	ΙΔ	6070/ 64 6 1 :			
Condition			Coating quality		n of 95% of the surface being			
Terminals of the capacitor shall be immersed into solder bath at 260±5°C for 1seconds or 400±10°C for 3 <sup>+1</sup> / <sub>0</sub> seconds to 1.5~2.0mm from the body of capacitor shall be left under the normal temperature and normal huming for 1~2 hours before measurement.    Criteria   Leakage current   Not more than the specified value.				minersed				
Seconds or 400±10°C for 3 -   seconds to 1.5~2.0mm from the body of capacitor. Then the capacitor shall be left under the normal temperature and normal huming for 1~2 hours before measurement.    Criteria>   Leakage current   Not more than the specified value.			<condition></condition>					
Resistance to solder heat test   Capacitor shall be left under the normal temperature and normal huming for 1~2 hours before measurement.			Terminals of the capacito	r shall be immersed int	o solder bath at 260±5°C for 10			
Resistance to solder heat test   Criteria>   Leakage current   Not more than the specified value.			1 seconds or $400 \pm 10^{\circ}$ C for	or $3^{+1}_{-0}$ seconds to 1.5~2.0	mm from the body of capacitor.			
Criteria>   Capacitance Change   Within ±10% of initial value.			Then the capacitor shall b	e left under the normal	temperature and normal humidit			
Leakage current  Not more than the specified value.  Capacitance Change  Within $\pm$ 10% of initial value.  tan $\delta$ Not more than the specified value.  Appearance  There shall be no leakage of electrolyte.   Condition> Temperature Cycle: According to IEC60384-4No.4.7 methods, capacitor shall be placed in an oven, the condition according as below:  Temperature  (1)+20°C  (2)Rated low temperature (-40°C) (-25°C)  (3)Rated high temperature (+105°C)  (1) to (3)=1 cycle, total 5 cycle  Criteria>  The characteristic shall meet the following requirement  Leakage current  Not more than the specified value.  Appearance  Not more than the specified value.  There shall be no leakage of electrolyte.  Condition>  Humidity Test:  According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at $40 \pm 2$ °C, the characteristic change is		Resistance to		surement.				
Capacitance Change Within $\pm$ 10% of initial value.  tan $\delta$ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.   **Condition**  Temperature Cycle: According to IEC60384-4No.4.7 methods, capacitor shall be placed in an oven, the condition according as below:	4.12	solder heat						
tan δ   Not more than the specified value.  Appearance   There shall be no leakage of electrolyte.    Condition		test	Leakage current	Not more than t	he specified value.			
Appearance    Appearance   There shall be no leakage of electrolyte.			Capacitance Change	Within ±10%	of initial value.			
Change of temperature test  Change of temperature (-40 °C) (-25 °C)   30 ± 2   Minutes (3)Rated high temperature (+105 °C)   30 ± 2   Minutes (1) to (3)=1 cycle, total 5 cycle  Criteria>  The characteristic shall meet the following requirement  Leakage current   Not more than the specified value.    Appearance   There shall be no leakage of electrolyte.  Condition>  Humidity Test:  According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change sets the characteristic change sets the condition of the condi			tan δ	Not more than t	he specified value.			
Temperature Cycle:According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below:			Appearance	There shall be r	o leakage of electrolyte.			
Temperature Cycle:According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below:			<condition></condition>					
placed in an oven, the condition according as below:  Temperature  Time  (1)+20°C  (2)Rated low temperature (-40°C) (-25°C)  (3)Rated high temperature (+105°C)  (1) to (3)=1 cycle, total 5 cycle  Criteria>  The characteristic shall meet the following requirement  Leakage current  Not more than the specified value. $tan \delta$ Not more than the specified value.  Appearance  There shall be no leakage of electrolyte.  Condition>  Humidity Test:  According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at $40\pm 2$ °C, the characteristic change is				rding to IEC60384-4No	4.7methods, capacitor shall be			
Change of temperature test  (1)+20°C (2)Rated low temperature (-40°C) (-25°C) (3)Rated high temperature (+105°C) (1) to (3)=1 cycle, total 5 cycle  Criteria> The characteristic shall meet the following requirement  Leakage current Not more than the specified value.  Appearance  Not more than the specified value.  Appearance  There shall be no leakage of electrolyte.  Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states are shall be reposed for 500 hours in an atmosphere of 90~95%R								
Change of temperature test  (2)Rated low temperature (-40°C) (-25°C) 30±2 Minutes (3)Rated high temperature (+105°C) 30±2 Minutes (1) to (3)=1 cycle, total 5 cycle  Criteria> The characteristic shall meet the following requirement  Leakage current Not more than the specified value.  tan δ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.  Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change shall be exposed for 500 hours in a final factor of the factor of the factor of the factor of the factor			Te	emperature	Time			
4.13       Change of temperature test       (3)Rated high temperature (+105°C)       30±2 Minutes         (1) to (3)=1 cycle, total 5 cycle       Criteria>          The characteristic shall meet the following requirement         Leakage current       Not more than the specified value.         Appearance       There shall be no leakage of electrolyte.         Condition>        Humidity Test:         According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change states and the content of the characteristic change states and the characteristic change states are content of the characteristic change states.			(1)+20°C	•				
4.13 temperature test  (3)Rated high temperature (+105°C) 30±2 Minutes (1) to (3)=1 cycle, total 5 cycle <criteria> The characteristic shall meet the following requirement  Leakage current Not more than the specified value.  tan δ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.  <condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change seems the state of the sta</condition></criteria>		Changa of	(2)Rated low temperature	$30\pm2$ Minutes				
test  (1) to (3)=1 cycle, total 5 cycle  Criteria> The characteristic shall meet the following requirement  Leakage current Not more than the specified value.  tan δ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.  Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change seems to the state of the st	4.13		(3)Rated high temper	rature (+105°C)	$30\pm2$ Minutes			
The characteristic shall meet the following requirement  Leakage current Not more than the specified value. $tan \delta$ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.   Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at $40\pm2^{\circ}$ C, the characteristic change s		-	(1) to (3)=1 cycle, to	tal 5 cycle				
Leakage current Not more than the specified value. $tan \delta$ Not more than the specified value.  Appearance There shall be no leakage of electrolyte.   Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at $40\pm2^{\circ}$ C, the characteristic change s								
$\frac{\tan \delta}{\text{Appearance}} \frac{\text{Not more than the specified value.}}{\text{There shall be no leakage of electrolyte.}}$ <b>Condition&gt;</b> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at $40\pm2^{\circ}\text{C}$ , the characteristic change so								
Appearance There shall be no leakage of electrolyte.  Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change s					1			
Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change statements.					1			
Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of 90~95%R H .at 40±2°C, the characteristic change s			Appearance	There shall be no le	eakage of electrolyte.			
According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 hours in an atmosphere of $90\sim95\%R$ H .at $40\pm2\%$ , the characteristic change s								
hours in an atmosphere of 90~95%R H .at $40\pm2$ °C, the characteristic change s			-					
					C, the characteristic change sha			
meet the following requirement. <criteria></criteria>				ement.				
				Not more than the sne	cified value			
4 14   Bump neut   G   G   G   G   G   G   G   G   G	4.14	•	-	•				
test   Capacitance Change   Within $\pm 20\%$ of initial value.   tan $\delta$   Not more than 120% of the specified value.		test						
Appearance There shall be no leakage of electrolyte.								
rippediance ribite shall be no leakage of electrolyte.			rippearance	I Here shan be no leak	ugo of ciccutific.			

Version	01		Page	9
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

test	22.4 or less Over 22.4 <a href="#">Criteria&gt;</a> The vent shall operate with n			itions suc	ch as flam	nes or disp	ersion o
	The maximum permissible at 120Hz and can be applied Table-1 The combined value of D.C rated voltage and shall not Frequency Multipliers:  Coefficient	ed at maxi C voltage	mum ope and the p	erating te	mperatur	e	ceed the
		0.45	0.55	0.70	0.00	1.00	
current)	390~1000	0.65	0.75	0.90	0.98	1.00	
	1200~3900	0.75	0.80	0.95	1.00	1.00	
	Maximum ermissible (ripple	22.4 or less   Over 22.4	22.4 or less   1   Over 22.4   10	Criteria> The vent shall operate with no dangerous condipieces of the capacitor and/or case.    Condition> The maximum permissible ripple current is the at 120Hz and can be applied at maximum operated voltage and shall not reverse voltage.    Frequency Multipliers:	Criteria> The vent shall operate with no dangerous conditions succeives of the capacitor and/or case.    Condition> The maximum permissible ripple current is the maximat 120Hz and can be applied at maximum operating to Table-1 The combined value of D.C voltage and the peak A.C rated voltage and shall not reverse voltage.    Frequency Multipliers:	Criteria> The vent shall operate with no dangerous conditions such as flampieces of the capacitor and/or case.    Condition> The maximum permissible ripple current is the maximum A.C of at 120Hz and can be applied at maximum operating temperatur Table-1 The combined value of D.C voltage and the peak A.C voltage strated voltage and shall not reverse voltage.    Frequency Multipliers:	22.4 or less   1   Over 22.4   10

Version (	01		Page	10
-----------	----	--	------	----

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances				
	Cadmium and cadmium compounds				
Heavy metals	Lead and lead compounds				
Heavy metals	Mercury and mercury compounds				
	Hexavalent chromium compounds				
	Polychlorinated biphenyls (PCB)				
Chloinated	Polychlorinated naphthalenes (PCN)				
organic	Polychlorinated terphenyls (PCT)				
compounds	Short-chain chlorinated paraffins(SCCP)				
	Other chlorinated organic compounds				
D : 1	Polybrominated biphenyls (PBB)				
Brominated .	Polybrominated diphenylethers(PBDE) (including				
organic	decabromodiphenyl ether[DecaBDE])				
Compounds Other brominated organic compounds					
Tributyltin comp	ounds(TBT)				
Triphenyltin com	pounds(TPT)				
Asbestos					
Specific azo com	pounds				
Formaldehyde					
Beryllium oxide					
Beryllium coppe	er				
Specific phthalate	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)				
Hydrofluorocarbo	on (HFC), Perfluorocarbon (PFC)				
Perfluorooctane s	pulfonates (PFOS)				
Specific Benzotri	azole				

Version 01	Page 11
------------	---------

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# SAMXON

#### **Attachment: Application Guidelines**

#### 1.Circuit Design

1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- (1) Effects of operating temperature on electrical parameters
  - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
  - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

#### 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

#### 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

#### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

#### (2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

#### (3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

#### (4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

#### 1.4 Using Two or More Capacitors in Series or Parallel

#### (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

#### (2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

#### 1.5 Capacitor Mounting Considerations

#### (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

#### (2) Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

#### (3) Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

#### (4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

#### (5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

Version 01	01		Page	12
------------	----	--	------	----

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# SAMXON

#### (6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

#### 1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

#### 1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

#### CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

#### 2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ.
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ .
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

#### 2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

#### 2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

#### 2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

#### 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

Version 01 Page 13
--------------------

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

#### 2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

#### 2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

#### 2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a  $1000\Omega$ , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

#### 5.1 Environmental Conditions

Version 01 Page 14	Version	01		Page	14
--------------------	---------	----	--	------	----

## ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

# **SAMXON**

The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

Version 01 Page 15	Version	01		rage	15
--------------------	---------	----	--	------	----